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A Scintillator-based Monitor for Real-Time, High-Resolution Imaging and Analysis of High-Intensity to <u>Single-Particle</u> Ion Beams

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Acknowledgement

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Office of Science and Office of Nuclear Physics

Phase-IIB: <u>Customer Centered Approach</u>

- FRIB customer & NP market: <u>No one-size-fits-all</u> product solution, especially for different energy ions, different ion energies, and different size beamlines.
- SBM platform "retrofit" approach requires no new *beamline real estate*.
- Customer installation & in-place diagnostic boxes greatly reduces system cost.
- Customer's in-house labor/expertise provides *flexibility* and *customization* at lowest possible cost, especially for *multiple* SBM identical platforms.

Implementation at FRIB

Phase-II to Phase-IIB:

Transition from standalone Six-Way-Cross Prototype in Phase-II with a 4 cm² (beam cross-section) scintillator, to a customizable PRODUCT platform in Phase-IIB with a 49 cm² (beam cross-section) scintillator integrated into existing NP beam monitoring diagnostic systems by I-S and customer. Major advantages: single particle imaging (first time ever), faster, more precise beamline tuning, eliminating new beamline real estate requirement and having to switch to surrogate "pilot" beam for tuning.

Application of Nuclear Physics device to NIH Cancer Institute for FLASH Radiotherapy

Program Overview

Goals

- 1. Advanced beam analysis in real-time over wide-range down to single-particles
- II: Critical components inserted into existing beam diagnostic systems by I-S or customer

Features

- Novel-use thin scintillators: very high sensitivity, clean imaging, low mass
- Optical system: ultra-fast large aperture optics for max light collection (i.e., F/0.9)

Demonstrated Specs

- ~ 20-40 μm position resolution, same as gafchromic film!
- Fast detection finds weak beams within ~ 0.3 sec; updated continuously at 1-3 Hz
- Updating false-color display in beam coordinate system
- Wide dynamic range: ~ 7 orders-of-magnitude, and down to single-ions
- Higher energy beams are transmissive
- Linear to <u>at least 5 orders-of-magnitude</u> in beam current

<u>Scintillators</u> – thin, non-hygroscopic & radiation damage resistant

Type 1: Hybrid Material (HM) – Inorganic polycrystalline ceramic hybrid

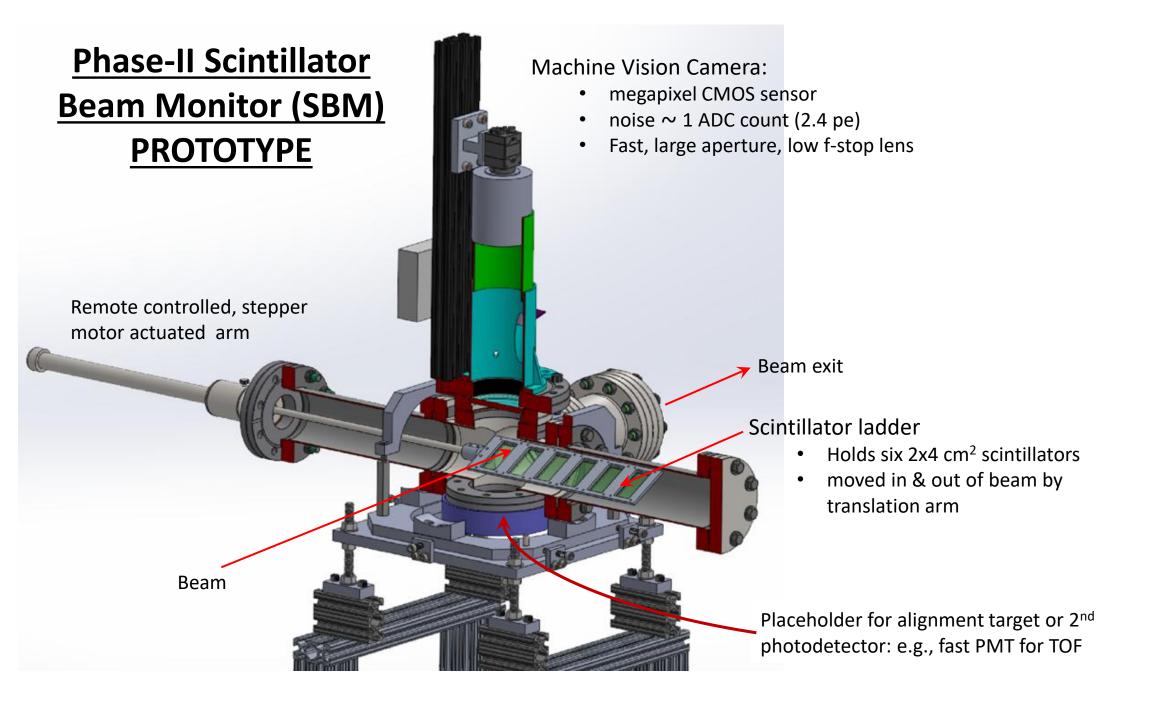
• *Thin*, ~ 300-500 µm water-equivalent thickness (WE)

Type 2: Polymer Material (PM) – Semicrystalline

• <u>Ultrathin</u> to Thin: tested 2 μm WE to < 300 μm WE

Both Types 1 & 2 have favorable properties:

- Excellent radiation hardness
- Sharp images essentially no internal reflections
- Non-hygroscopic
- Transmissive (depending on ion and beam energy)
- High light emittance for their respective type

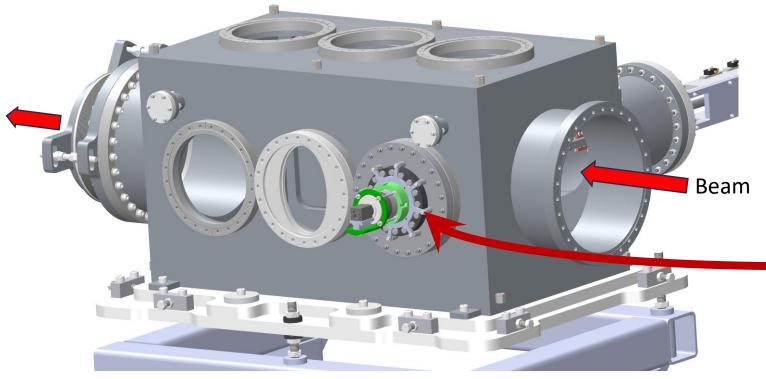


ReA3-SECAR* Scintillator Beam Monitor (Phase-IIB)

*SECAR = <u>Separator for Capture Reactions</u>

Camera Assembly

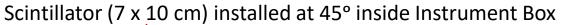


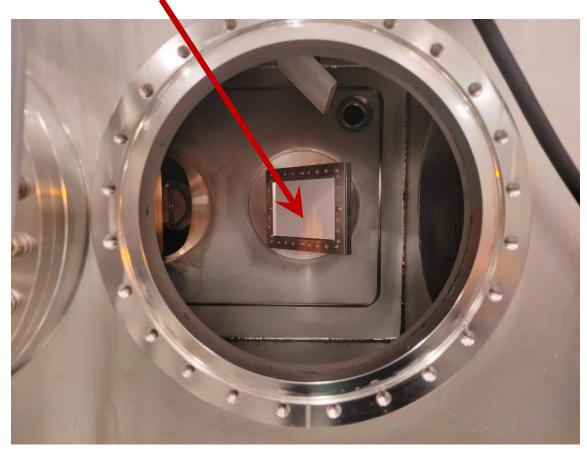


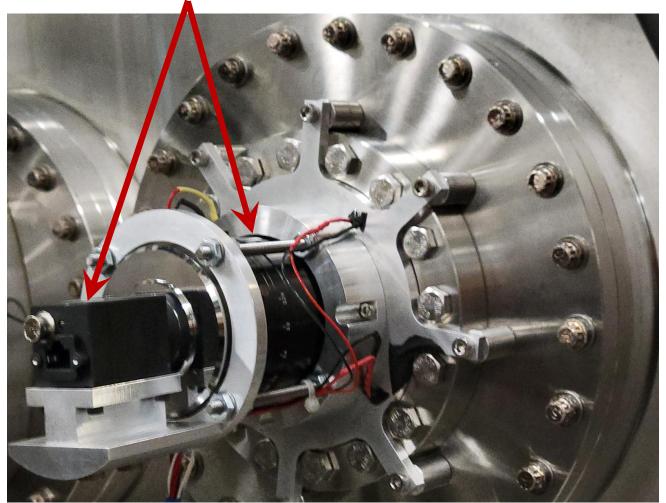


Installed ReA3-SECAR Beam Monitor PRODUCT

Camera Assembly mounted to Instrument Box

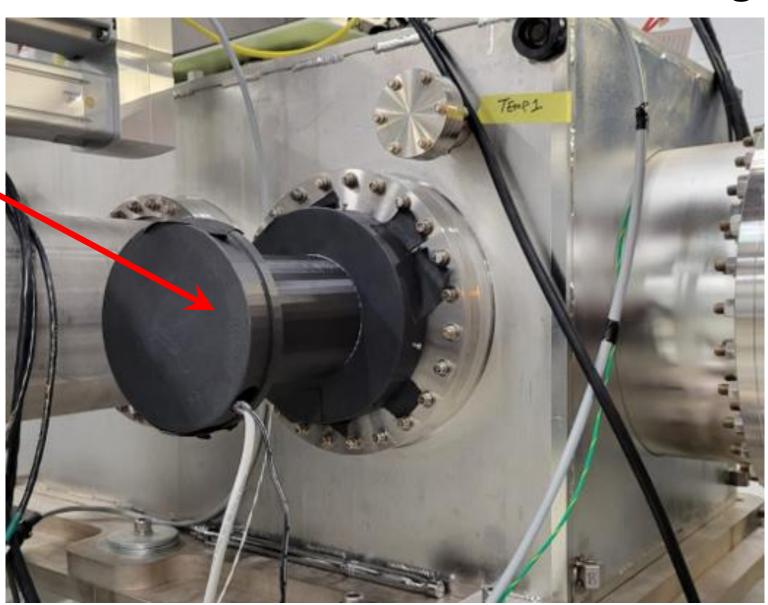






ReA3-SECAR SBM Camera-Lens Housing

3D-Printed
Camera-Lens
Light-Tight
Housing

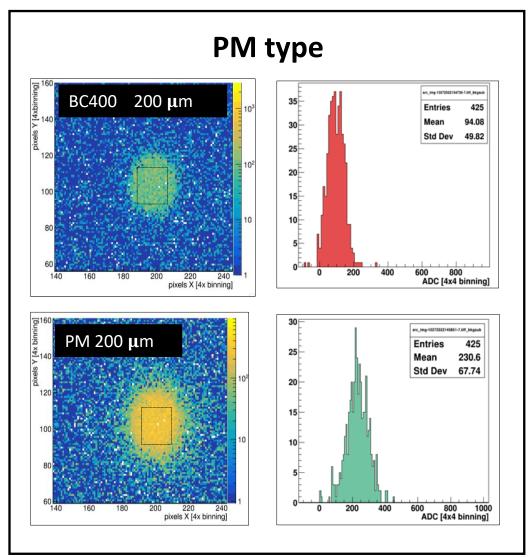


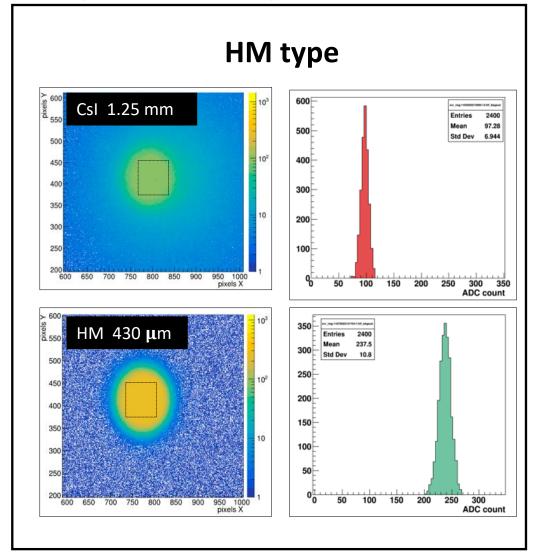
Test Beams (Phase-II and Phase-IIB)

Location	Source	Energy [MeV/u]
UM Physics Lab	β (⁹⁰ Sr) & α (²⁴¹ Am)	~1
Michigan Ion Beam Laboratory (MIBL)	p	1 - 6
Facility for Rare Isotope Beams (FRIB) (FRIB SECAR Installation 7/11/2024)	⁸⁶ Kr ⁺²⁶ ³⁵ Cl ⁺¹⁵ & ¹⁴ N ⁺⁶	2.75 4.5
Notre Dame Radiation Laboratory (NDRL)	e ⁻	8
UM Hospital (Radiation Oncology)	e ⁻	6 -16

Scintillator Efficiency Comparisons to Benchmarks

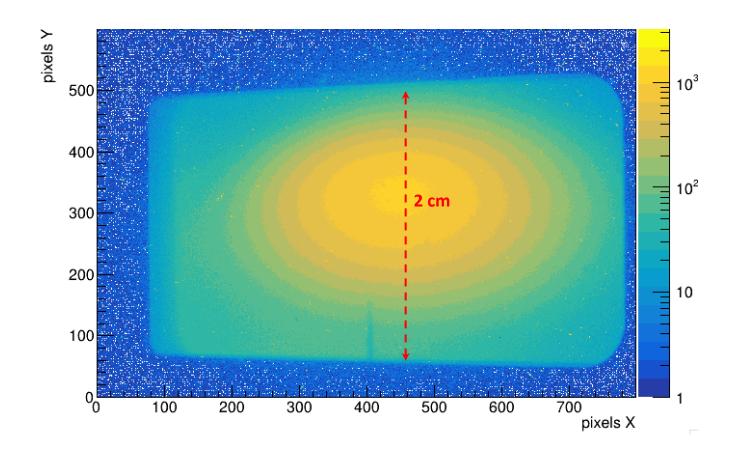
3 mm collimated electron beam (β⁻ source ⁹⁰Sr)





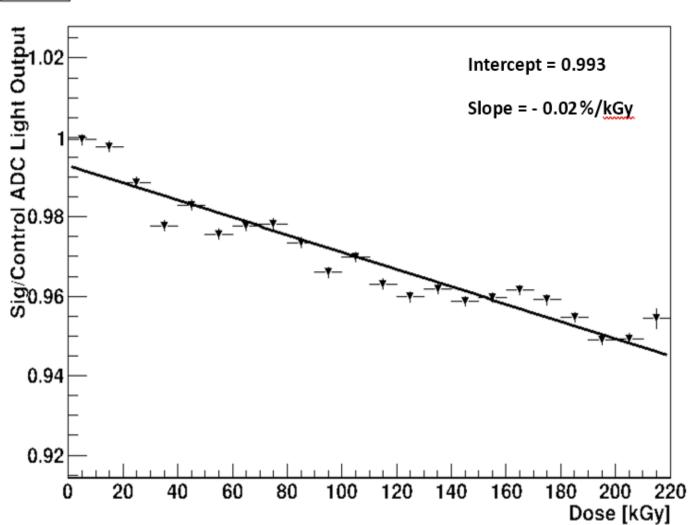
Beam Image on HM at NDRL (camera coordinates)

- Single 2 ns duration pulse (1.9 Gy) at a peak current of 1 A
- Peak dose rate = 950 MGy/s
- 8 MeV electrons



Radiation Hardness of HM Scintillator

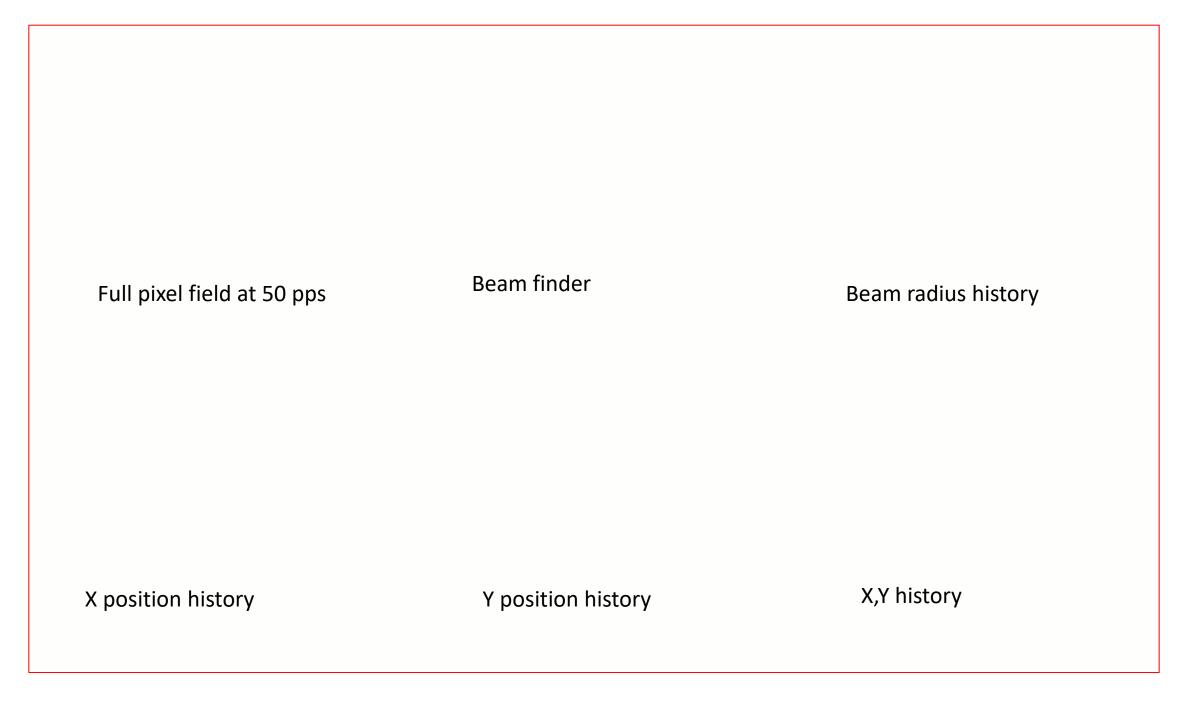




For proton-FLASH-RT @ 10 Gy/patient, 20 patients/day, 5 days/week, the dose is 1 kGy/wk or 50 kGy/yr.

Rad hardness measured over **212** kGy or > 4 yrs, max. signal loss of \sim 4%, or < 1% signal loss/yr, i.e. 0.02%/kGy.

Signal loss is reduced by spontaneous rad damage recovery & correctable with internal UV calibration system.



DAQ Functionality (Phase-II)

1. Loads text file of configuration parameters:

- pixel field range and spatial offsets
- frame exposure time
- acquisition mode (triggered or asynchronous)
- pixel binning
- ADC digitization and gain factor

2. <u>Image processing in real-time:</u>

- background subtraction
- faulty pixel removal
- affine (perspective) matrix transformations and rotations for display in beam coordinate system

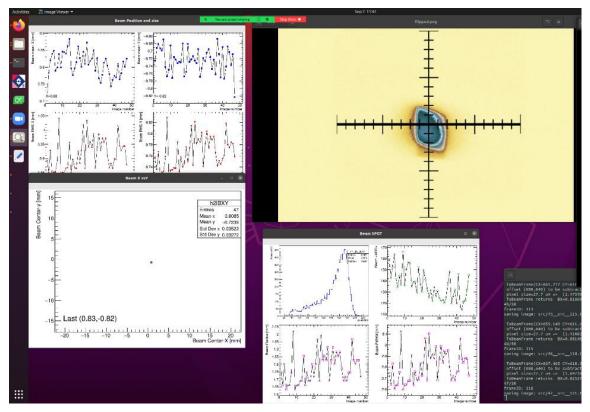
3. <u>Image analysis in real-time:</u>

- beam finding
- beam profiling (centroids, RMS widths)
- peak amplitude

4. Display

- color-coded beam image
- real-time analysis results in updating graphics
- updates at 1 Hz
- 5. Data transfer to storage media for offline analysis

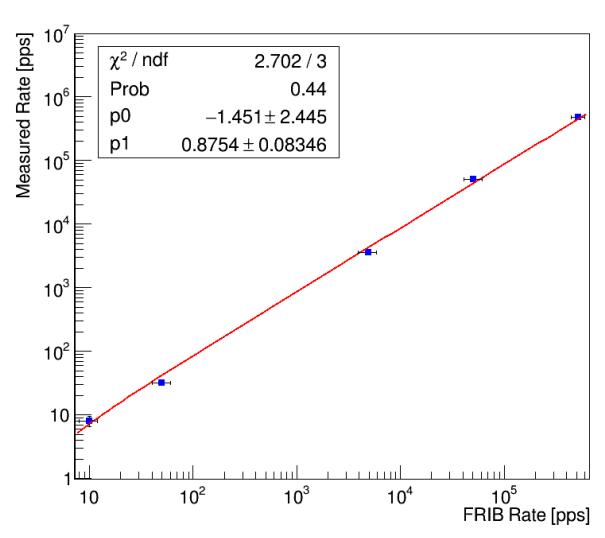
Screen capture of display in Control Room



Shown above:

- beam false color
- 2D position history
- beam FWHM and radius
- 1D updating X,Y centroids
- peak ADC and RMS

⁸⁶Kr⁺²⁶ Beam Current in HM Scintillator (Measured Rate vs. FRIB "Given" Rate)



Result 1:

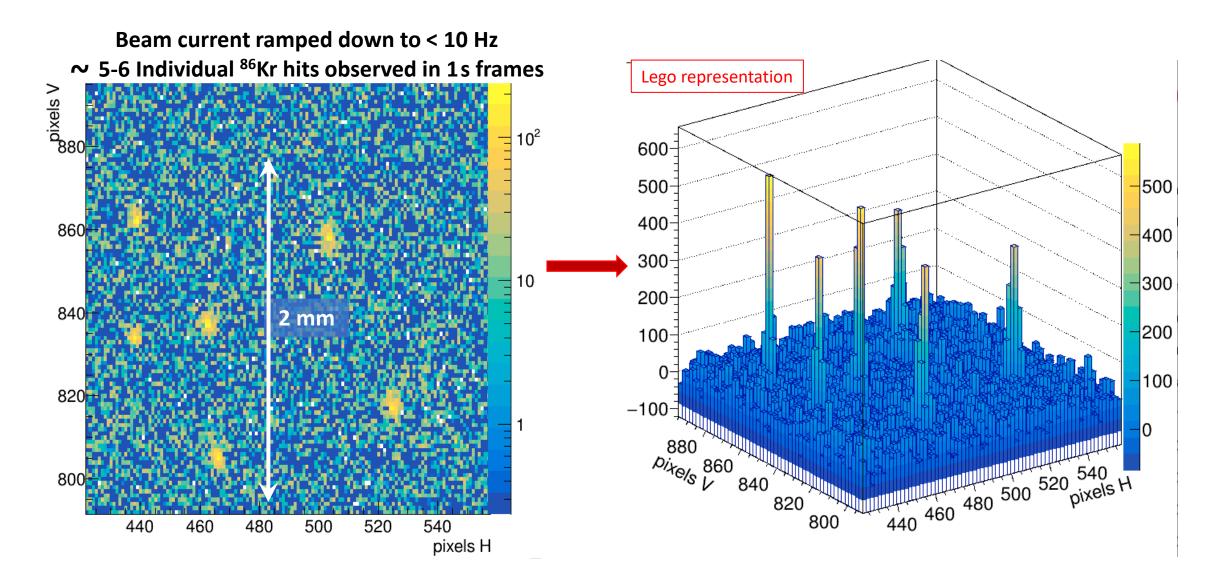
The <u>SBM can measure beam currents</u> that are now determined by 4 different FRIB devices:

- Faraday Cup
- MCP detector
- Silicon detector
- Calibrated Beam Attenuator

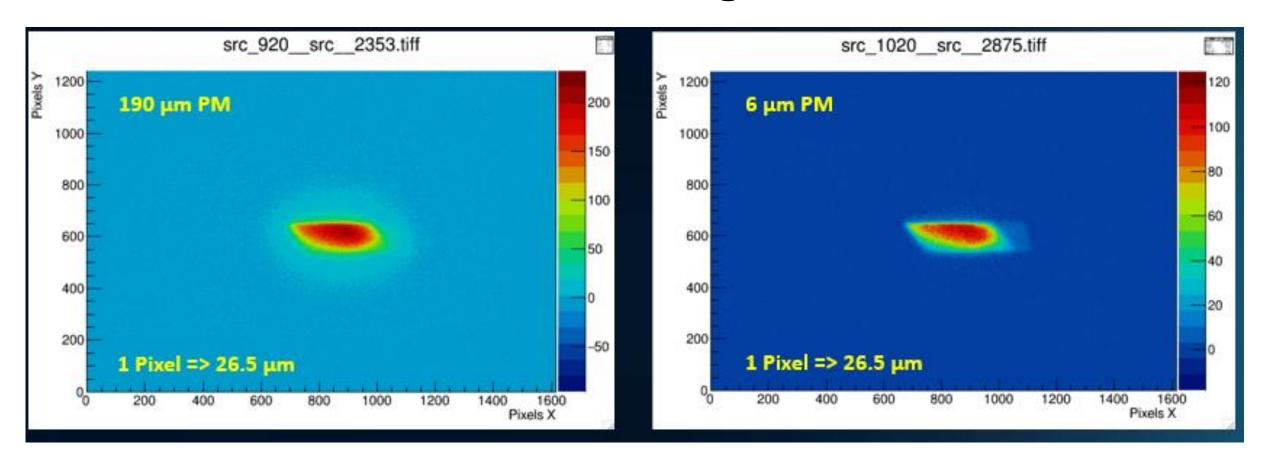
Result 2:

SBM measurement is *linear over more than* **5 orders-of-magnitude** (the full range has not been determined)

"Single Particle" hits/images (86Kr+26 Beam Imaging in HM Scintillator)

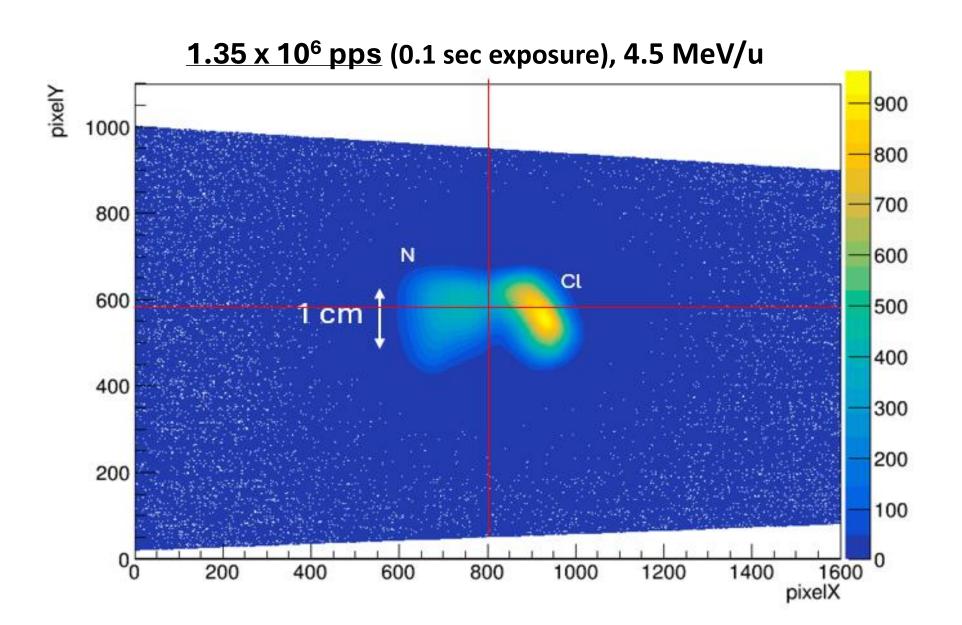


Phase-II Beamline Images of 86Kr+26

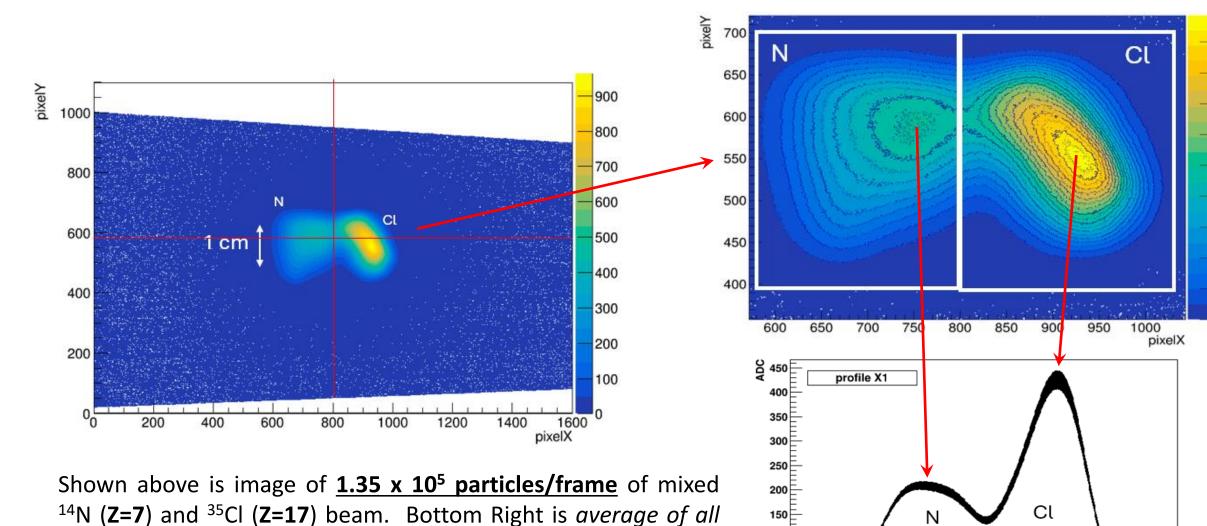


Above beamline images captured in real-time of same 2.75 MeV/u beam of 86 Kr $^{+26}$ (**Z=36**) particles irradiating two different thickness 2x2 cm **PM** scintillators at a rate of $^{5.2}$ x $^{10^5}$ pps. Image on Left was with 190 µm thick **PM**; image on Right was with 6 µm thick **PM** that transmits $^{75\%}$ of the beam. Z-bar intensity scale is different for the two images with max intensity of Left image twice that of Right image.

Phase-IIB Mixed Beam of ¹⁴N⁺⁶ and ³⁵CI⁺¹⁵



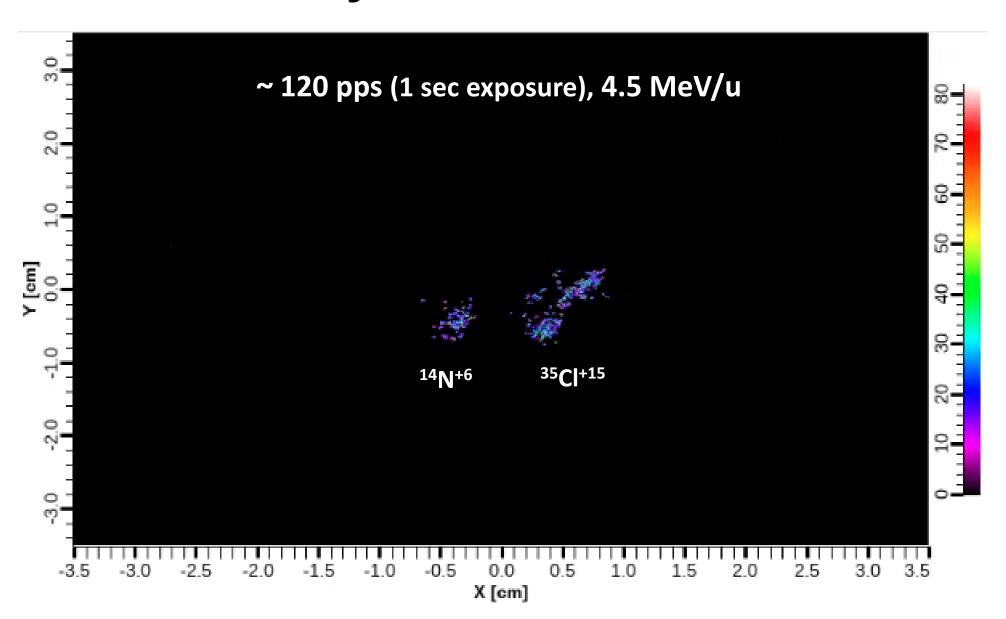
Mixed Beam Analysis of ¹⁴N⁺⁶ and ³⁵CI⁺¹⁵



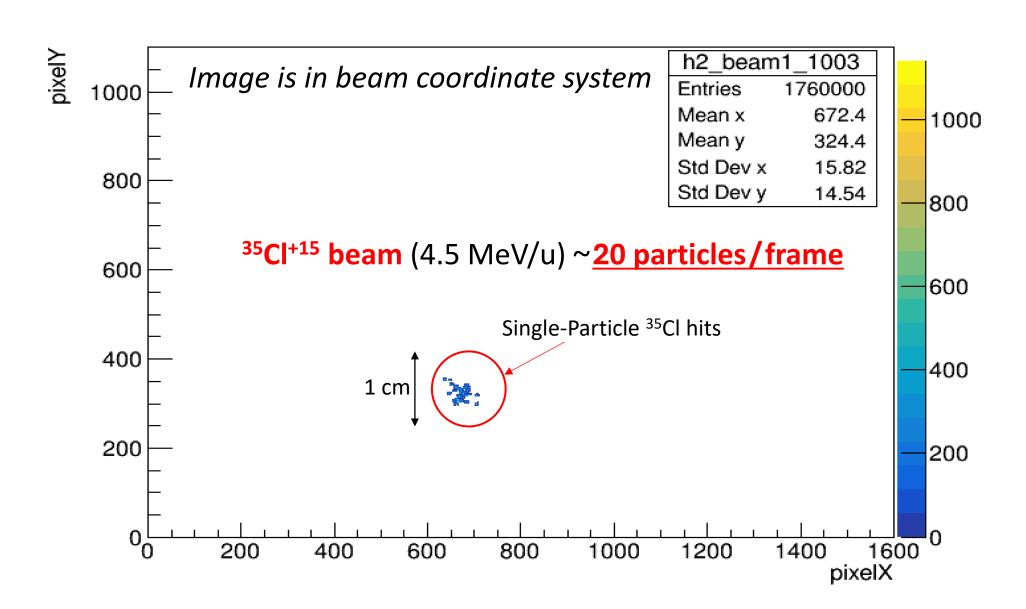
ADC counts along Y axis as a function of X axis beam position.

pixel X

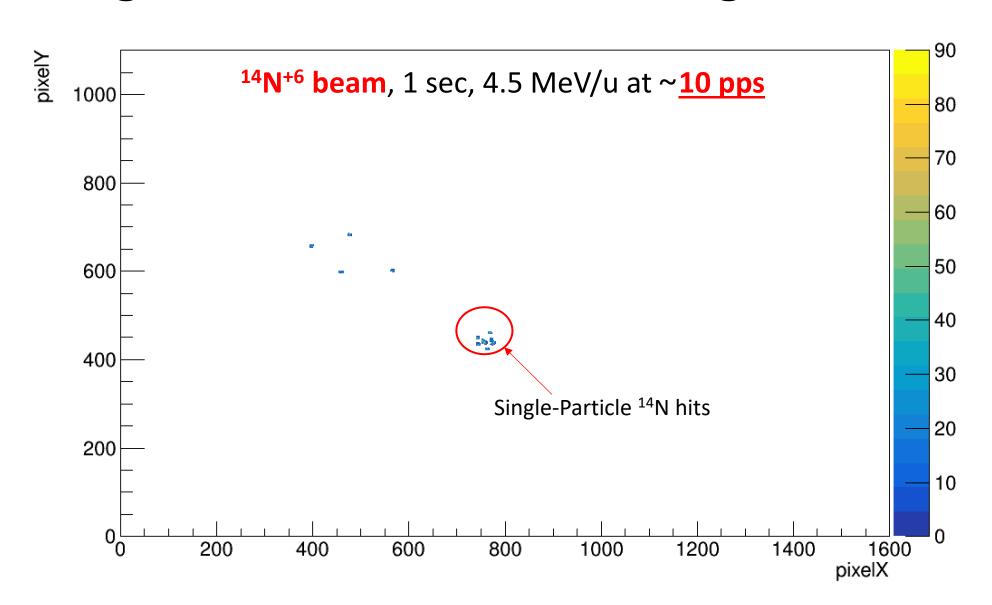
Ultra-Low Intensity Mixed Beam of ¹⁴N⁺⁶ and ³⁵CI⁺¹⁵



"Single Particle" Beamline Images of 35CI+15



"Single Particle" Beamline Images of 14N+6



Summary

- 1) SBM provides real-time, precise 2D beam tuning, profiling & imaging with spatial resolution ~ 20-40 μm
- 2) High sensitivity & dynamic range: single-particles to $\sim 10^7$ pps/cm² (~ 10 nA, depending on particle/energy)
- 3) <u>Linear Response</u> to > 5 orders-of-magnitude for ⁸⁶Kr⁺²⁶
- 4) Novel applications and radiation hardness for two specialized scintillator materials
 - PM: thin to ultra-thin materials produce clean imaging and accurate profiling
 - PM in <u>air</u> at rates of O(10) Gy/s \rightarrow <u>no "observable" degradation</u> over first 9 kGy
 - Ultra-thin PM tested: from \sim **1- 200 \mum** sample thickness
 - HM: <u>order-of-magnitude higher signal output</u> than much thicker CsI(Tl) standard
 - HM in air at rates of O(10) Gy/s \rightarrow minimal degradation of 0.02%/kGy
- 5) SBM design operates in high vacuum (or in air)
- 6) SBM real-time analysis for NP is < 1 sec, but for proton-FLASH-RT is $< 2 \mu s$ for camera operating at 20,000 fps
- 7) Scintillators can be remotely inserted in beam or changed without breaking vacuum.